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CCS L04

SJ

INDUSTRY STANDARD OF THE PEOPLE'S REPUBLIC OF CHINA

SJ 21347-2018

Low temperature device and component extremely low temperature screening test method

低温器件与组件极低温度筛选试验方法

(English Translation)

Issued by: Ministry of Industry and Information Technology

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1 Foreword

SJ 21347-2018 is issued by Ministry of Industry and Information Technology.

The SJ prefix, without a suffix, marks a mandatory standard: within its scope, compliance is required.

The document runs to 8 pages in English translation.

2 Scope Preview

SJ 21347-2018 is filed under Chinese Standard Classification L04, in the field of electronic components and information technology.

This catalogue holds 1,191 other SJ standards without an ICS number.

In this catalogue, SJ standards carry edition years from 1965 to 2021.

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3 About this standard

Sector: Electronics Industry Standard

Issued by: Ministry of Industry and Information Technology

English translation: about 8 pages (approximate)

Chinese original: about 12,120 characters

4 Related standards

Standards on related subjects:

GB/T 34986-2017 - Methods for product accelerated testing

GB/T 32910.3-2016 - Data centre - Resource utilization - Part 3: Energy usage effectiveness requirements and measuring methods

SJ 20524-1995 - Measuring methods of shielding effectiveness of materials

SJ/T 10668-2023 - Electronic assembly technical terminology

SJ 21348-2018 - Environment test methods for superconducting devices

SJ 21346-2018 - Low temperature low loss transmission line insulation component test method

5 Classification and status

Chinese Standard Classification (CCS): L 04

Prefix SJ: mandatory standard.

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